

UNIVERSITY OF CALIFORNIA
College of Engineering
Department of Electrical Engineering and Computer Sciences

EE290D
Spring 1999

Handout #24
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HOMEWORK ASSIGNMENT #3
Due Thursday, March 11 (in class)

Problem 1: Liquid-Crystal Cell Design

- a) Calculate the optimum cell gap (d) for an active-matrix TN-LCD employing a liquid crystal material with $\Delta n=0.1$. (Use $\lambda_0=550$ nm.)
- b) Consider the transmittance characteristics of a normally-black TN-LCD shown in Figure 4 of Handout #19. Plot the display contrast ratio (T_{ON}/T_{OFF}) as a function of cell gap, for $0 < d < 12$ μm . You should assume that the transmission (T) of the display is equal to the sum of the Red, Green, and Blue transmissions.
- c) Why is the normally-white mode used in almost all commercial AMLCDs?

Problem 2: Reflective LCD Technology

- a) What are the two methods by which full-color images can be rendered with reflective LC displays? What is the advantage of each method?
- b) What is the main advantage of bistable LCDs? What is the main disadvantage of bistable LCDs?

Problem 3: Active Matrix vs. Passive Matrix LCDs

- a) Compare the characteristics of a passive-matrix STN-LCD against those of an active-matrix TN-LCD, by filling out the 3rd and 5th columns in the following table:

Parameter	PMLCD	>, <, or =	AMLCD	Brief Justification
Contrast Ratio				
Viewing Angle				
Response Time				
# Gray Levels				
Aperture Ratio				
Cost				

- b) In an active-matrix LCD, the liquid-crystal material must have very high resistivity in order for grayscale images to be displayed. Calculate the minimum required LC resistivity for an SVGA display (60 Hz frame rate) with a cell gap of 5 μm , a pixel ITO area of 6×10^4 μm^2 , a pixel capacitance ($C_{LC} + C_{storage}$) of 1 pF, if the maximum allowable change in pixel voltage during a frame time is 20 mV.

Problem 4: TFT sizing in AMLCDs

A pixel TFT in an active-matrix circuit operates in the linear region. Pixels are usually addressed using a scan-line voltage of 20V (to sequentially turn on each row of TFTs, and a pixel TFT is usually sized to allow the pixel capacitance to be charged to the data-line voltage within one-tenth of the line time. The maximum difference in pixel voltage from frame to frame is 10 V (corresponding to a fully driven pixel).

- a) Typical amorphous-Si TFT performance parameters are $\mu_{\text{eff}}=0.7 \text{ cm}^2/\text{Vs}$ and $V_T=2.5\text{V}$. **Estimate** the minimum W/L ratio required for an a-Si pixel TFT in a video-rate VGA display. (Assume gate-dielectric areal capacitance = $2.5 \times 10^{-8} \text{ F/cm}^2$, and pixel capacitance = 1 pF.)
- b) Typical “low-temperature” poly-Si n-channel TFT performance parameters are $\mu_{\text{eff}}=50 \text{ cm}^2/\text{Vs}$ and $V_T=2.0\text{V}$. **Estimate** the minimum W/L ratio required for a poly-Si pixel TFT in a video-rate VGA display. (Assume gate SiO_2 thickness = 100 nm, and pixel capacitance = 1 pF.)
- c) Following the methodology described in the paper entitled “Transistor sizing for AMLCD integrated TFT drive circuits” (Handout #25), estimate the W/L ratio required for a poly-Si buffer TFT of a single-ended scan-line driver for a video-rate VGA display.